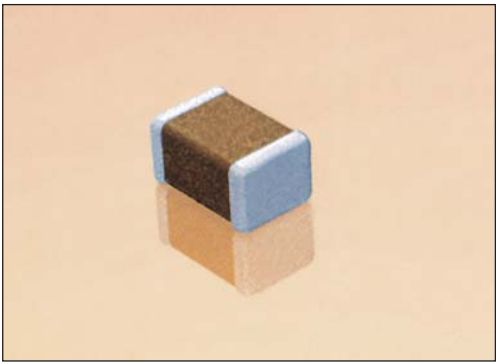


# X5R Dielectric

## General Specifications



### GENERAL DESCRIPTION

- General Purpose Dielectric for Ceramic Capacitors
- EIA Class II Dielectric
- Temperature variation of capacitance is within  $\pm 15\%$  from  $-55^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$
- Well suited for decoupling and filtering applications
- Available in High Capacitance values (up to  $100\mu\text{F}$ )

### PART NUMBER (SEE PAGE 2 FOR COMPLETE PART NUMBER EXPLANATION)

**1210**

**Size**  
(L" x W")

**4**

**Voltage**  
4 = 4V  
6 = 6.3V  
Z = 10V  
Y = 16V  
3 = 25V  
D = 35V  
5 = 50V

**D**

**Dielectric**  
D = X5R

**107**

**Capacitance Code (In pF)**  
2 Sig. Digits +  
Number of  
Zeros

**M**

**Capacitance Tolerance**  
K =  $\pm 10\%$   
M =  $\pm 20\%$

**A**

**Failure Rate**  
A = N/A

**T**

**Terminations**  
T = Plated Ni  
and Sn

**2**

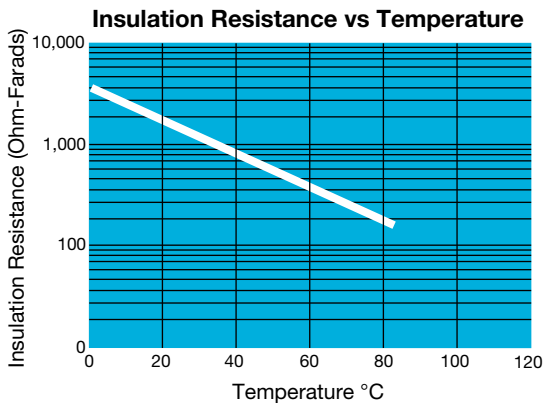
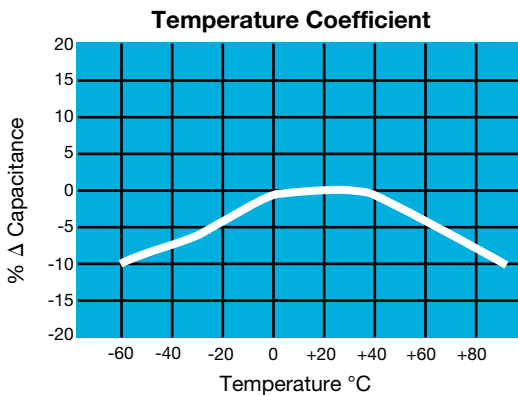
**Packaging**  
2 = 7" Reel  
4 = 13" Reel  
7 = Bulk Cass.  
9 = Bulk

**A**

**Special Code**  
A = Std.

NOTE: Contact factory for availability of Tolerance Options for Specific Part Numbers.  
Contact factory for non-specified capacitance values.

### TYPICAL ELECTRICAL CHARACTERISTICS



## Specifications and Test Methods

Parameter/Test		X5R Specification Limits	Measuring Conditions	
<b>Operating Temperature Range</b>		-55°C to +85°C	Temperature Cycle Chamber	
<b>Capacitance</b>		Within specified tolerance	Freq.: 1.0 kHz $\pm$ 10% Voltage: 1.0Vrms $\pm$ .2V For Cap > 10 $\mu$ F, 0.5Vrms @ 120Hz	
<b>Dissipation Factor</b>		$\leq$ 2.5% for $\geq$ 50V DC rating $\leq$ 3.0% for 25V DC rating $\leq$ 12.5% Max. for 16V DC rating and lower Contact Factory for DF by PN		
<b>Insulation Resistance</b>		10,000M $\Omega$ or 500M $\Omega$ - $\mu$ F, whichever is less	Charge device with rated voltage for 120 $\pm$ 5 secs @ room temp/humidity	
<b>Dielectric Strength</b>		No breakdown or visual defects	Charge device with 300% of rated voltage for 1-5 seconds, w/charge and discharge current limited to 50 mA (max)	
<b>Resistance to Flexure Stresses</b>	Appearance	No defects	Deflection: 2mm Test Time: 30 seconds 	
	Capacitance Variation	$\leq$ $\pm$ 12%		
	Dissipation Factor	Meets Initial Values (As Above)		
	Insulation Resistance	$\geq$ Initial Value x 0.3		
<b>Solderability</b>		$\geq$ 95% of each terminal should be covered with fresh solder	Dip device in eutectic solder at 230 $\pm$ 5°C for 5.0 $\pm$ 0.5 seconds	
<b>Resistance to Solder Heat</b>	Appearance	No defects, <25% leaching of either end terminal	Dip device in eutectic solder at 260°C for 60 seconds. Store at room temperature for 24 $\pm$ 2 hours before measuring electrical properties.	
	Capacitance Variation	$\leq$ $\pm$ 7.5%		
	Dissipation Factor	Meets Initial Values (As Above)		
	Insulation Resistance	Meets Initial Values (As Above)		
	Dielectric Strength	Meets Initial Values (As Above)		
<b>Thermal Shock</b>	Appearance	No visual defects	Step 1: -55°C $\pm$ 2°	30 $\pm$ 3 minutes
	Capacitance Variation	$\leq$ $\pm$ 7.5%	Step 2: Room Temp	$\leq$ 3 minutes
	Dissipation Factor	Meets Initial Values (As Above)	Step 3: +85°C $\pm$ 2°	30 $\pm$ 3 minutes
	Insulation Resistance	Meets Initial Values (As Above)	Step 4: Room Temp	$\leq$ 3 minutes
	Dielectric Strength	Meets Initial Values (As Above)	Repeat for 5 cycles and measure after 24 $\pm$ 2 hours at room temperature	
	<b>Load Life</b>		Meets Initial Values (As Above)	Charge device with 1.5X rated voltage in test chamber set at 85°C $\pm$ 2°C for 1000 hours (+48, -0). Note: Contact factory for *optional specification part numbers that are tested at < 1.5X rated voltage.
<b>Load Humidity</b>	Appearance	No visual defects	Remove from test chamber and stabilize at room temperature for 24 $\pm$ 2 hours before measuring.  Store in a test chamber set at 85°C $\pm$ 2°C/ 85% $\pm$ 5% relative humidity for 1000 hours (+48, -0) with rated voltage applied.  Remove from chamber and stabilize at room temperature and humidity for 24 $\pm$ 2 hours before measuring.	
	Capacitance Variation	$\leq$ $\pm$ 12.5%		
	Dissipation Factor	$\leq$ Initial Value x 2.0 (See Above)		
	Insulation Resistance	$\geq$ Initial Value x 0.3 (See Above)		
	Dielectric Strength	Meets Initial Values (As Above)		

